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Kind regards,
Team Nexperia

## DATA SHEET



PBSS5520X
20 V, 5 A
PNP low $\mathrm{V}_{\text {CEsat }}$ (BISS) transistor
Product data sheet
Supersedes data of 2004 Jun 23

## FEATURES

- High $\mathrm{h}_{\text {FE }}$ and low $\mathrm{V}_{\text {CEsat }}$ at high current operation
- High collector current $\mathrm{I}_{\mathrm{C}}: 5 \mathrm{~A}$
- High efficiency leading to less heat generation.


## APPLICATIONS

- Medium power peripheral drivers (e.g. fans and motors)
- Strobe flash units for digital still cameras and mobile phones
- Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- Battery chargers
- Supply line switching.


## DESCRIPTION

PNP low $\mathrm{V}_{\text {CEsat }}$ (BISS) transistor in a SOT89 (SC-62) plastic package.
NPN complement: PBSS4520X.

## MARKING

| TYPE NUMBER | MARKING CODE ${ }^{(1)}$ |
| ---: | :---: |
| PBSS5520X | *1K |

## Note

1. $\quad$ * p : made in Hong Kong.

* $=\mathrm{t}$ : made in Malaysia.
* $=\mathrm{W}$ : made in China.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MAX. | UNIT |
| :--- | :--- | :--- | :--- |
| $\mathrm{V}_{\text {CEO }}$ | collector-emitter voltage | -20 | V |
| $\mathrm{I}_{\mathrm{C}}$ | collector current (DC) | -5 | A |
| $\mathrm{I}_{\mathrm{CM}}$ | peak collector current | -10 | A |
| $\mathrm{R}_{\text {CEsat }}$ | equivalent on-resistance | 54 | $\mathrm{~m} \Omega$ |

PINNING

| PIN | DESCRIPTION |
| :---: | :--- |
| 1 | emitter |
| 2 | collector |
| 3 | base |



ORDERING INFORMATION

| TYPE NUMBER | PACKAGE |  |  |
| :--- | :---: | :--- | :---: |
|  | NAME | DESCRIPTION | VERSION |
| PBSS5520X | SC-62 | plastic surface mounted package; collector pad for <br> good heat transfer; 3 leads | SOT89 |

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## LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CBO }}$ | collector-base voltage | open emitter | - | -20 | V |
| $\mathrm{V}_{\text {CEO }}$ | collector-emitter voltage | open base | - | -20 | V |
| $\mathrm{V}_{\text {EBO }}$ | emitter-base voltage | open collector | - | -5 | V |
| $\mathrm{I}_{\mathrm{C}}$ | collector current (DC) |  | - | -5 | A |
| $\mathrm{I}_{\text {CM }}$ | peak collector current | $\mathrm{t}_{\mathrm{p}} \leq 1 \mathrm{~ms}$ | - | -10 | A |
| $\mathrm{I}_{\text {CRP }}$ | repetitive peak collector current | notes 1 and 2 | - | -6.5 | A |
| $\mathrm{I}_{\mathrm{B}}$ | base current (DC) |  | - | -1 | A |
| $\mathrm{I}_{\text {BM }}$ | peak base current | $\mathrm{t}_{\mathrm{p}} \leq 1 \mathrm{~ms}$ | - | -2 | A |
| $\mathrm{P}_{\text {tot }}$ | total power dissipation | $\mathrm{T}_{\mathrm{amb}} \leq 25^{\circ} \mathrm{C}$ <br> notes 1 and 2 <br> note 2 <br> note 3 <br> note 4 <br> note 5 |  | $\begin{array}{\|l} 2.5 \\ 0.55 \\ 1 \\ 1.4 \\ 1.6 \end{array}$ | $\begin{aligned} & \mathrm{W} \\ & \mathrm{w} \\ & \mathrm{w} \\ & \mathrm{w} \\ & \mathrm{w} \end{aligned}$ |
| $\mathrm{T}_{\text {stg }}$ | storage temperature |  | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{j}}$ | junction temperature |  | - | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {amb }}$ | ambient temperature |  | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |

## Notes

1. Operated under pulsed conditions; pulse width $\mathrm{t}_{\mathrm{p}} \leq 10 \mathrm{~ms}$; duty cycle $\delta \leq 0.2$.
2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector $1 \mathrm{~cm}^{2}$.
4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector $6 \mathrm{~cm}^{2}$.
5. Device mounted on a $7 \mathrm{~cm}^{2}$ ceramic printed-circuit board, $1 \mathrm{~cm}^{2}$ single-sided copper, tin-plated.

(1) FR4 PCB; $6 \mathrm{~cm}^{2}$ mounting pad for collector.
(2) FR4 PCB; $1 \mathrm{~cm}^{2}$ mounting pad for collector.
(3) FR4 PCB; standard footprint.

Fig. 2 Power derating curves.

$$
\begin{aligned}
& 20 \mathrm{~V}, 5 \mathrm{~A} \\
& \text { PNP low } \mathrm{V}_{\text {CEsat }} \text { (BISS) transistor }
\end{aligned}
$$

## THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\text {th }(\mathrm{j}-\mathrm{a}}$ | thermal resistance from junction to ambient | in free air |  |  |
|  |  | notes 1 and 2 | 50 | K/W |
|  |  | note 2 | 225 | K/W |
|  |  | note 3 | 125 | K/W |
|  |  | note 4 | 90 | K/W |
|  |  | note 5 | 80 | K/W |
| $\mathrm{R}_{\mathrm{th}(\mathrm{j}-\mathrm{s})}$ | thermal resistance from junction to soldering point |  | 16 | K/W |

## Notes

1. Operated under pulsed conditions; pulse width $\mathrm{t}_{\mathrm{p}} \leq 10 \mathrm{~ms}$; duty cycle $\delta \leq 0.2$.
2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector $1 \mathrm{~cm}^{2}$.
4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector $6 \mathrm{~cm}^{2}$.
5. Device mounted on a $7 \mathrm{~cm}^{2}$ ceramic printed-circuit board, $1 \mathrm{~cm}^{2}$ single-sided copper, tin-plated.


Mounted on FR4 printed-circuit board; standard footprint.
(1) $\delta=1$.
(3) $\delta=0.5$.
(5) $\delta=0.2$.
(7) $\delta=0.05$.
(9) $\delta=0.01$.
(2) $\delta=0.75$.
(4) $\delta=0.33$.
(6) $\delta=0.1$.
(8) $\delta=0.02$.
(10) $\delta=0$.

Fig. 3 Transient thermal impedance as a function of pulse time; typical values.

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Mounted on FR4 printed-circuit board; mounting pad for collector $1 \mathrm{~cm}^{2}$.
(1) $\delta=1$.
(3) $\delta=0.5$.
(5) $\delta=0.2$.
(7) $\delta=0.05$.
(9) $\delta=0.01$.
(2) $\delta=0.75$.
(4) $\delta=0.33$.
(6) $\delta=0.1$.
(8) $\delta=0.02$.
(10) $\delta=0$.

Fig. 4 Transient thermal impedance as a function of pulse time; typical values.


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20 V, 5 A
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```


## CHARACTERISTICS

$\mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {cbo }}$ | collector-base cut-off current | $\mathrm{V}_{\mathrm{CB}}=-20 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=0 \mathrm{~A}$ | - | - | -100 | nA |
|  |  | $\mathrm{V}_{C B}=-20 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=0 \mathrm{~A} ; \mathrm{T}_{\mathrm{j}}=150{ }^{\circ} \mathrm{C}$ | - | - | -50 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {ebo }}$ | emitter-base cut-off current | $\mathrm{V}_{\text {EB }}=-5 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=0 \mathrm{~A}$ | - | - | -100 | nA |
| $\mathrm{I}_{\text {CES }}$ | collector-emitter cut-off current | $\mathrm{V}_{C E}=-20 \mathrm{~V} ; \mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}$ | - | - | -100 | nA |
| $\mathrm{h}_{\text {FE }}$ | DC current gain | $\begin{aligned} \hline \mathrm{V}_{\mathrm{CE}} & =-2 \mathrm{~V} \\ \mathrm{I}_{\mathrm{C}} & =-0.5 \mathrm{~A} ; \text { note } 1 \\ \mathrm{I}_{\mathrm{C}} & =-1 \mathrm{~A} ; \text { note } 1 \\ \mathrm{I}_{\mathrm{C}} & =-2 \mathrm{~A} ; \text { note } 1 \\ \mathrm{I}_{\mathrm{C}} & =-5 \mathrm{~A} \text {; note } 1 \end{aligned}$ | $\begin{array}{\|l} 300 \\ 275 \\ 250 \\ 150 \end{array}$ | $\begin{aligned} & 430 \\ & 400 \\ & 360 \\ & 260 \end{aligned}$ | $\left[\begin{array}{l} - \\ - \\ - \\ - \end{array}\right.$ |  |
| $\mathrm{V}_{\text {CEsat }}$ | collector-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=-0.5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-5 \mathrm{~mA}$ | - | -45 | -70 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=-1 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-10 \mathrm{~mA}$ | - | -70 | -110 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=-2.5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-125 \mathrm{~mA}$; note 1 | - | -100 | -150 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=-4 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-200 \mathrm{~mA}$; note 1 | - | -150 | -230 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=-5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-500 \mathrm{~mA}$; note 1 | - | -170 | -270 | mV |
| $\mathrm{R}_{\text {CEsat }}$ | equivalent on-resistance | $\mathrm{I}_{\mathrm{C}}=-5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-500 \mathrm{~mA}$; note 1 | - | 34 | 54 | $\mathrm{m} \Omega$ |
| $V_{\text {BEsat }}$ | base-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=-4 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=-200 \mathrm{~mA}$; note 1 | - | -0.9 | -1.05 | V |
|  |  | $\mathrm{I}_{\mathrm{C}}=-5 \mathrm{~A}$; $\mathrm{I}_{\mathrm{B}}=-500 \mathrm{~mA}$; note 1 | - | -0.96 | -1.1 | V |
| $\mathrm{V}_{\text {BEon }}$ | base-emitter turn-on voltage | $\mathrm{V}_{\mathrm{CE}}=-2 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=-2 \mathrm{~A}$ | - | -0.74 | -0.85 | V |
| $\mathrm{f}_{\mathrm{T}}$ | transition frequency | $\begin{aligned} & \mathrm{I}_{\mathrm{C}}=-100 \mathrm{~mA} ; \mathrm{V}_{\mathrm{CE}}=-10 \mathrm{~V} ; \\ & \mathrm{f}=100 \mathrm{MHz} \end{aligned}$ | 80 | 100 | - | MHz |
| $\mathrm{C}_{\mathrm{c}}$ | collector capacitance | $\begin{aligned} & V_{C B}=-10 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=\mathrm{i}_{\mathrm{e}}=0 \mathrm{~A} ; \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ | - | 130 | 150 | pF |

## Note

1. Pulse test: $\mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02$.
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(1) $\mathrm{I}_{\mathrm{B}}=-64 \mathrm{~mA}$.
(5) $\mathrm{I}_{\mathrm{B}}=-38.4 \mathrm{~mA}$.
(8) $\mathrm{I}_{\mathrm{B}}=-19.2 \mathrm{~mA}$.
(2) $I_{B}=-57.6 \mathrm{~mA}$.
(6) $\mathrm{I}_{\mathrm{B}}=-32 \mathrm{~mA}$.
(9) $\mathrm{I}_{\mathrm{B}}=-12.8 \mathrm{~mA}$
(3) $I_{B}=-51.2 \mathrm{~mA}$.
(7) $\mathrm{I}_{\mathrm{B}}=-25.6 \mathrm{~mA}$.
(10) $\mathrm{I}_{\mathrm{B}}=-6.4 \mathrm{~mA}$.
(4) $\mathrm{I}_{\mathrm{B}}=-44.8 \mathrm{~mA}$.

Fig. 6 Collector current as a function of collector-emitter voltage; typical values.

$V_{C E}=-2 \mathrm{~V}$.
(1) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$.
(2) $\mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$.
(3) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$.

Fig. 8 DC current gain as a function of collector current; typical values.

$\mathrm{V}_{\mathrm{CE}}=-2 \mathrm{~V}$.
(1) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$.
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
(3) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$.

Fig. 7 Base-emitter voltage as a function of collector current; typical values.

$I_{C} / I_{B}=20$.
(1) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$.
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
(3) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$.

Fig. 9 Equivalent on-resistance as a function of collector current; typical values.

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$\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=20$.
(1) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$.
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
(3) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$.

Fig. 10 Collector-emitter saturation voltage as a function of collector current; typical values.

$\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=20$.
(1) $\mathrm{T}_{\text {amb }}=-55^{\circ} \mathrm{C}$.
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
(3) $\mathrm{T}_{\text {amb }}=150^{\circ} \mathrm{C}$.

Fig. 12 Base-emitter saturation voltage as a function of collector current; typical values.

$\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
(1) $\mathrm{I} / \mathrm{I}_{\mathrm{B}}=100$.
(2) $\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=50$.
(3) $\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=10$.

Fig. 11 Collector-emitter saturation voltage as a function of collector current; typical values.


Fig. 13 Base-emitter turn-on voltage as a function of collector current; typical values.

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20 V, 5 A
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```


## Reference mounting conditions



Fig. 14 FR4, standard footprint.


Fig. 15 FR4, mounting pad for collector $1 \mathrm{~cm}^{2}$.


Fig. 16 FR4, mounting pad for collector $6 \mathrm{~cm}^{2}$.

$$
\begin{aligned}
& 20 \mathrm{~V}, 5 \mathrm{~A} \\
& \text { PNP low } \mathrm{V}_{\text {CEsat }} \text { (BISS) transistor }
\end{aligned}
$$

## PACKAGE OUTLINE

DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ | $\mathbf{b}_{\mathbf{p} 1}$ | $\mathbf{b}_{\mathbf{p} 2}$ | $\mathbf{b}_{\mathbf{p} 3}$ | $\mathbf{c}$ | $\mathbf{D}$ | $\mathbf{E}$ | $\mathbf{e}$ | $\mathbf{e}_{\mathbf{1}}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{w}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.6 | 0.48 | 0.53 | 1.8 | 0.44 | 4.6 | 2.6 | 3.0 | 1.5 | 4.25 | 1.2 | 0.13 |
|  | 1.4 | 0.35 | 0.40 | 1.4 | 0.23 | 4.4 | 2.4 |  |  | 3.75 | 0.8 |  |


| OUTLINE <br> VERSION | REFERENCES |  |  |  | EUROPEAN <br> PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | JEITA |  |  |  |
| SOT89 |  | TO-243 | SC-62 |  | - |  |

# 20 V, 5 A <br> PNP low $\mathrm{V}_{\text {CEsat }}$ (BISS) transistor 

PBSS5520X

## DATA SHEET STATUS

| DOCUMENT <br> STATUS ${ }^{(1)}$ | PRODUCT STATUS ${ }^{(2)}$ | DEFINITION |
| :---: | :---: | :---: |
| Objective data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary data sheet | Qualification | This document contains data from the preliminary specification. |
| Product data sheet | Production | This document contains the product specification. |

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